

PCN#20150602000 Assembly Site move from Amkor K1 to TI Melaka for DP83846AVHG/NOPB Device Change Notification / Sample Request

Dear Customer:

Amkor K1 (Korea) is closing its facility by 2015. This product change announcement is to support transfer of products in the TQFP package to alternate sites. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days to ensure you can complete your evaluation and product transfer to the new site can be completed prior to the HIJI site closure.

The changes discussed within this PCN will not take effect any earlier than **90** days from the date of this notification, unless customer agreement has been reached on an earlier implementation of the change. This notification period is per TI's standard process.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (<u>PCN_ww_admin_team@list.ti.com</u>).

Sincerely,

PCN Team SC Business Services

PCN# 20150602000 Attachment: 1

Products Affected:

According to our records, there are the affected device(s) that you have purchased within the past twenty-four (24) months. Technical details of this Product Change follow on the next page(s).

PCN Number:	201	20150602000 PCN Date: 06/05/2015					06/05/2015			
Title: Assembly Site move from Amkor K1 to TI Melaka for DP83846AVHG/NOPB Device										
Customer Contact:	PCN Manager Dept: Quality Services									
Proposed 1 st Ship Date: 09/05		5/20	V2015 Estimate Availabi		d Sample ity:		Date provided at sample request			
Change Type:			_							
Assembly Site				Design				Wafer Bump Site		
Assembly Process			Data Sheet				Wafer Bum			
	Assembly MaterialsMechanical Specification			Part number change Test Site				Wafer Bum Wafer Fab		
Packing/Shipping				Test Process			Wafer Fab Materials			
		3						Wafer Fab Process		
				PC	N Details	5				
Description of Change	ge:									
Assembly Site move from Amkor K1 to TI Melaka for Select Device. No material differences between sites.										
Reason for Change:										
Closure of the Amkor	K1 ass	embly	fac	ility. (Continuity c	of supply.				
Anticipated impact of	on Foi	rm, Fit	:, Fu	unctio	n, Quality	or Reliabi	ilit	y (positive	/ negative):	
None.										
Changes to product	Changes to product identification resulting from this PCN:									
Sample Product Shi			(<mark>n</mark>	ot actu	al product	label)				
Amkor K1	Group 1: Assembly SiteAmkor K1Assembly Site Origin (22L)ASO: AMN									
TI Melaka (TIEI	(AN							O: GNZ	—	
INSTRUMENTS INSTRUMENTS 2DC:Image: Construction of the second secon										
ASSEMBLY SITE CODES: AMKOR K1 =7, TIEMA = 1										
Product Affected Group:										
DP83846AVHG/NOPB										

Qualification Report Amkor K1 Closure and L/TQFP transfer to TIEMA

Product Description

Part Number	Process	Package / # Leads	Moisture Sensitivity Level
DP83846AVHC2WQ Product Data	CMOS7	LQFP 80 Leads	3
DP83640TVVX Product Data	CMOS9T	LQFP 48 Leads	3
LP5221TM QBS Process Data	CMOS7	WCP 20Bumps	1
DP83851DVN QBS Package Data	CMOS7	LQFP 144 Leads	3
DP83848VV (QBS Product Family Data)	CMOS9T	LQFP 48 Leads	3

- QBS: Qual By Similarity – Reliability data from similar product family, wafer fab process and package may be used to support qualification

Qualification Results

Data Displayed as: Total failed / Total sample size

Test Methods	Conditions	Product Data DP83846A VHC2WQ	Product Data DP83640TVVX	Process QBS Data LP5521TM Lot1,2,3	Product Family Data DP83848VV	QBS Package Data DP83851DVN Lot1,2,3
ELFR JESD22-A108	125ºC (48hrs)			0/231	0/805	0/800
HTOL JESD22-A108	125°C (408hrs)		0/77	0/1145	0/240	0/77
ACLV JESD22-A102	121ºC, 100% 15PSI (96hrs)					0/60
HAST JESD22-A101	130ºC, 85% 13.3PSI (96hrs)				0/80	0/77
TMCL JESD22-A104	-65ºC to 150ºC (500cyc)					0/120
HTSL JESD22-A103	150ºC (1000hrs)					0/45
ESDH JESD22-A114	1.5kOhm, 100pF Room Temp (2000V)	0/3	0/3		0/3	
ESDC JESD22-C101	JESD22-C101 (1000V)	0/3	0/3		0/3	
ESDM JESD22-A115	JESD22-A115 (300V)	0/3	0/3		0/3	
LUPS	Over Voltage and Current Test (28ºC / 85ºC)	0/6	0/6		0/6	

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com